Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/693,421	CHEN, ERNEST C.
Examiner	**Art Unit**
Emmanuel, Bayard	2638

SEARCHED			
Class	Subclass	Date	Examiner
375	326	3/14/06	ei-s
	327		
	329		
V	260		
375	279		
370	210	3/14/06	ei-s

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
375	309	3/14/06	ei-s

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
ei ASI	3/13/06	ei-s